

## N-Channel Enhancement-Mode MOSFET

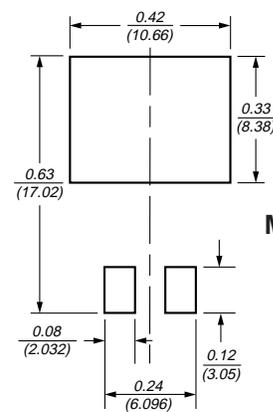
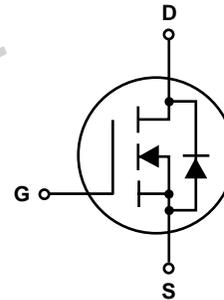
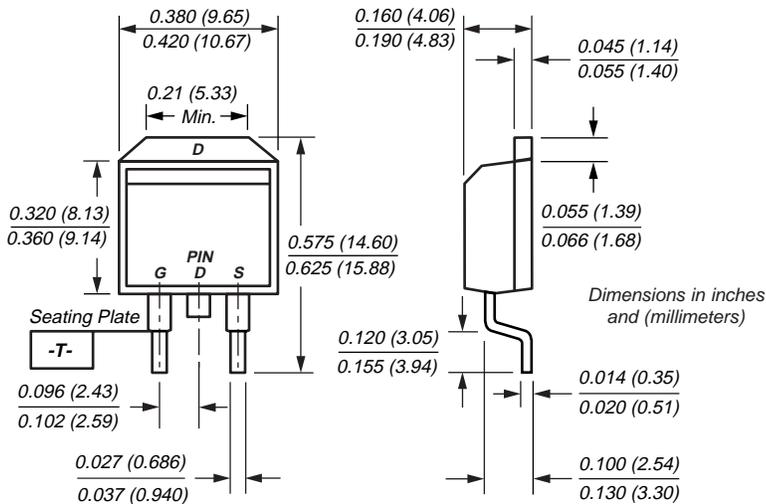
$V_{DS}$  30V  $R_{DS(ON)}$  6.5m $\Omega$   $I_D$  80A



TRENCH  
GENFET®

New Product

### TO-263AB



Mounting Pad  
Layout

## Mechanical Data

**Case:** JEDEC TO-263 molded plastic body

**Terminals:** Leads solderable per MIL-STD-750, Method 2026

**High temperature soldering guaranteed:**  
250°C/10 seconds at terminals

**Mounting Position:** Any    **Weight:** 1.3g

## Features

- Advanced Trench Process Technology
- High Density Cell Design for Ultra Low On-Resistance
- Specially Designed for Low Voltage DC/DC Converters
- Fast Switching for High Efficiency

## Maximum Ratings and Thermal Characteristics (T<sub>C</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V <sub>DS</sub>	30	V
Gate-Source Voltage	V <sub>GS</sub>	±20	
Continuous Drain Current <sup>(1)</sup>	I <sub>D</sub>	80	A
Pulsed Drain Current	I <sub>DM</sub>	240	
Maximum Power Dissipation	P <sub>D</sub>	T <sub>A</sub> = 25°C 69.4	W
		T <sub>A</sub> = 100°C 27.8	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C
Lead Temperature (1/8" from case for 5 sec.)	T <sub>L</sub>	275	°C
Junction-to-Case Thermal Resistance	R <sub>θJC</sub>	1.8	°C/W
Junction-to-Ambient Thermal Resistance <sup>(2)</sup>	R <sub>θJA</sub>	40	°C/W

**Notes:** (1) Maximum DC current limited by the package

(2) 1-in<sup>2</sup> 2oz. Cu PCB mounted

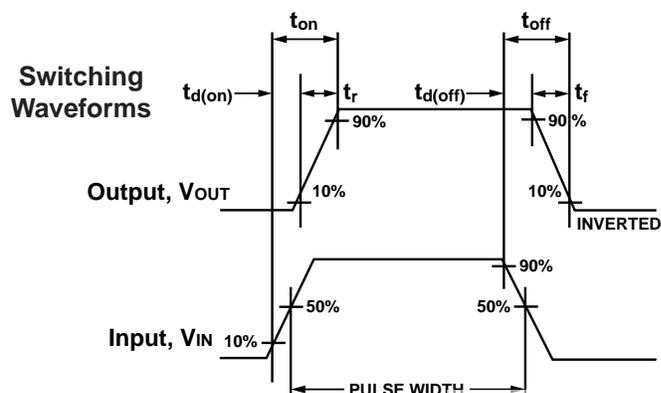
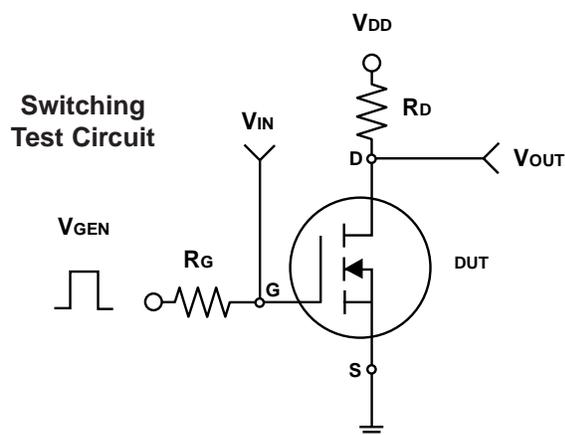
## N-Channel Enhancement-Mode MOSFET

### Electrical Characteristics (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
<b>Static</b>						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA	30	–	–	V
Drain-Source On-State Resistance <sup>(1)</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 38A	–	5.8	6.5	mΩ
		V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 31A	–	8.5	9.5	
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA	1.0	–	3.0	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 30V, V <sub>GS</sub> = 0V	–	–	1.0	μA
Gate-Body Leakage	I <sub>GSS</sub>	V <sub>GS</sub> = ±20V, V <sub>DS</sub> = 0V	–	–	±100	nA
On-State Drain Current <sup>(1)</sup>	I <sub>D(on)</sub>	V <sub>DS</sub> ≥ 5V, V <sub>GS</sub> = 10V	75	–	–	A
Forward Transconductance <sup>(1)</sup>	g <sub>fs</sub>	V <sub>DS</sub> = 15V, I <sub>D</sub> = 38A	–	61	–	S
<b>Dynamic</b>						
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> =15V, I <sub>D</sub> =38A, V <sub>GS</sub> =5V	–	32.5	46	nC
		V <sub>DS</sub> = 15V, V <sub>GS</sub> = 10V I <sub>D</sub> = 38A	–	63	90	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> = 15V, V <sub>GS</sub> = 10V I <sub>D</sub> = 38A	–	11	–	ns
Gate-Drain Charge	Q <sub>gd</sub>		–	11	–	
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 15V, R <sub>L</sub> = 15Ω I <sub>D</sub> ≅ 1A, V <sub>GEN</sub> = 10V R <sub>G</sub> = 6Ω	–	13	26	ns
Turn-On Rise Time	t <sub>r</sub>		–	16	29	
Turn-Off Delay Time	t <sub>d(off)</sub>		–	94	132	
Turn-Off Fall Time	t <sub>f</sub>		–	38	57	
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> = 15V, V <sub>GS</sub> = 0V f = 1.0MHz	–	3240	–	pF
Output Capacitance	C <sub>oss</sub>		–	625	–	
Reverse Transfer Capacitance	C <sub>rss</sub>		–	285	–	
<b>Source-Drain Diode</b>						
Max. Diode Forward Current	I <sub>S</sub>	–	–	–	75	A
Diode Forward Voltage	V <sub>SD</sub>	I <sub>S</sub> = 38A, V <sub>GS</sub> = 0V	–	0.9	1.3	V

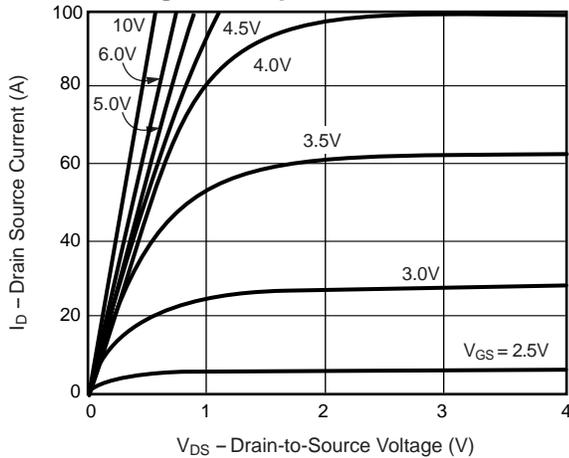
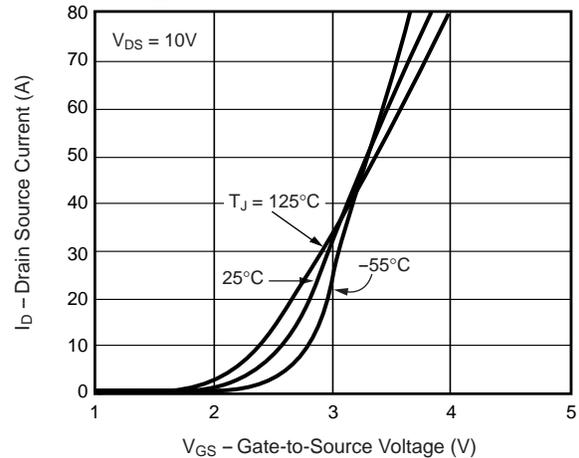
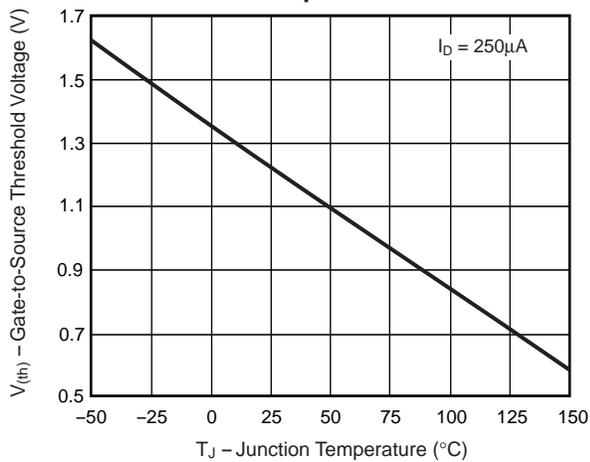
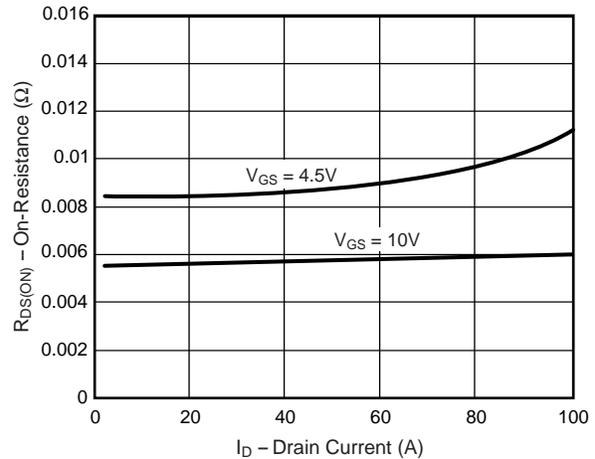
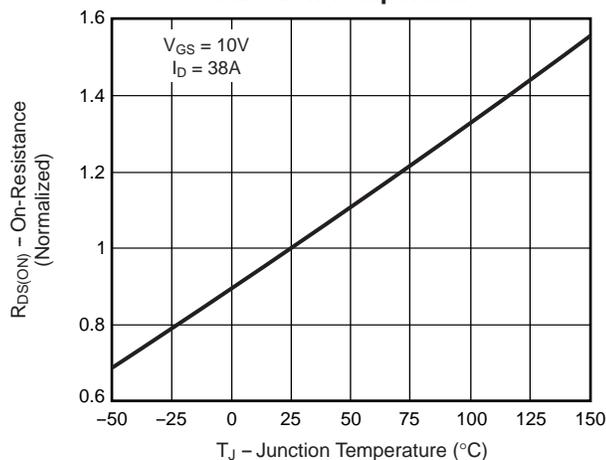
**Note:**

(1) Pulse test; pulse width ≤ 300 μs, duty cycle ≤ 2%



## N-Channel Enhancement-Mode MOSFET

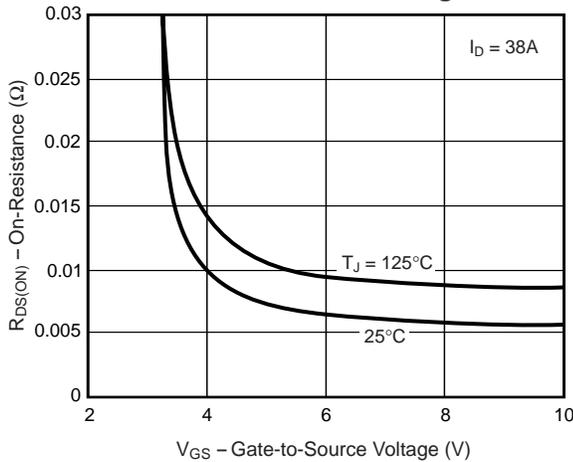
### Ratings and Characteristic Curves ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

**Fig. 1 – Output Characteristics**

**Fig. 2 – Transfer Characteristics**

**Fig. 3 – Threshold Voltage vs.  
Temperature**

**Fig. 4 – On-Resistance vs.  
Drain Current**

**Fig. 5 – On-Resistance vs.  
Junction Temperature**


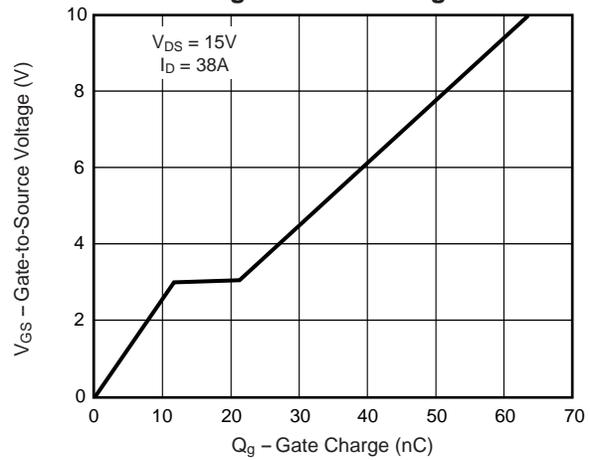
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**Ratings and Characteristic Curves** ( $T_A = 25^\circ\text{C}$  unless otherwise noted)

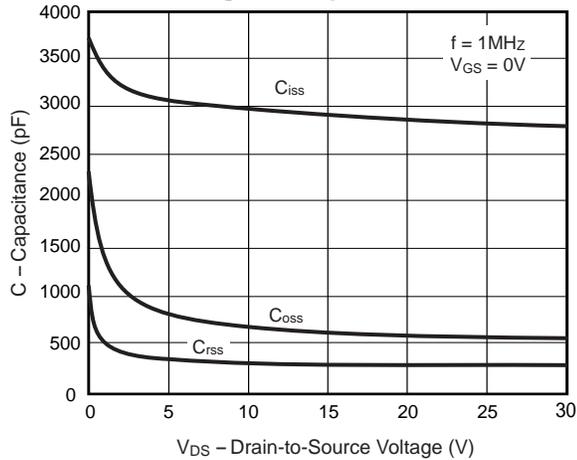
**Fig. 6 – On-Resistance vs. Gate-to-Source Voltage**



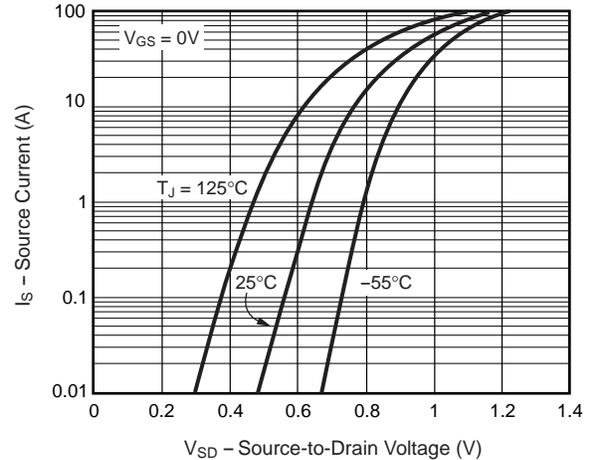
**Fig. 7 – Gate Charge**



**Fig. 8 – Capacitance**



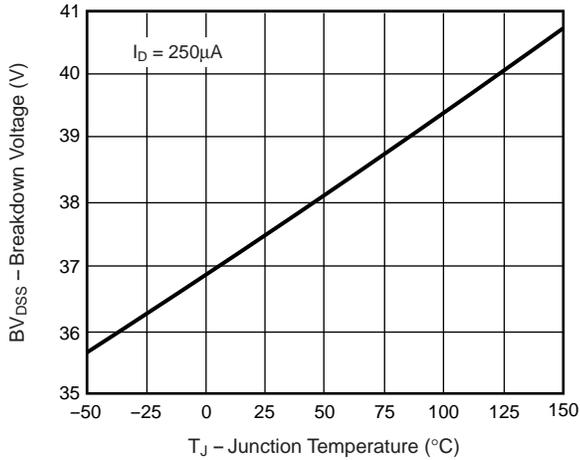
**Fig. 9 – Source-Drain Diode Forward Voltage**



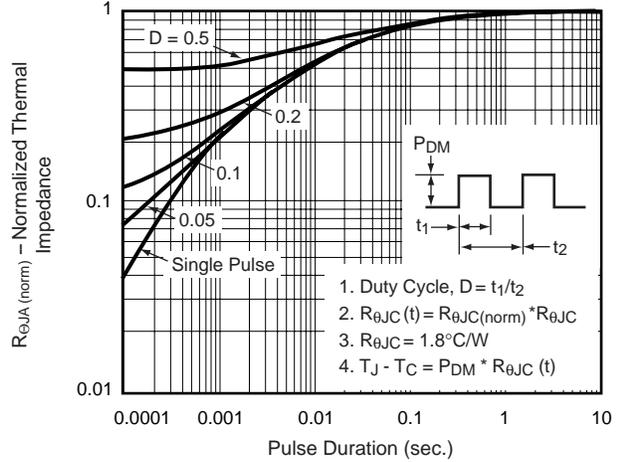
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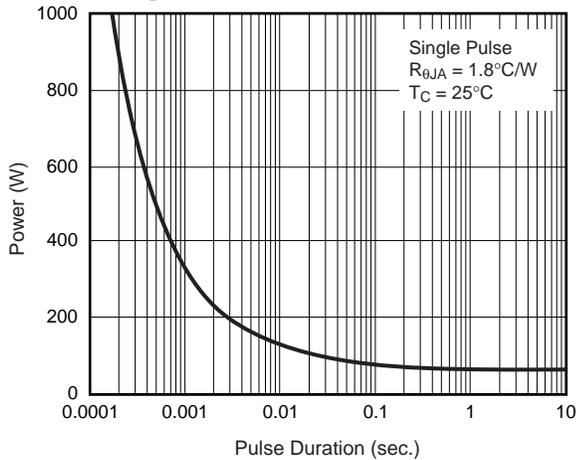
**Fig. 10 – Breakdown Voltage vs. Junction Temperature**



**Fig. 11 – Transient Thermal Impedance**



**Fig. 12 – Power vs. Pulse Duration**



**Fig. 13 – Maximum Safe Operating Area**

